V _{RRM}	=	4500 V
I _{FAVM}	=	900 A
I _{FSM}	=	16 kA
V _{F0}	=	1.8 V
r _F	=	0.9 mΩ
V _{DClink}	=	2400 V

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Fast Recovery Diode 5SDF 07H4501

Doc. No. 5SYA1111-02 Sep. 01

- Patented free-floating silicon technology
- Low switching losses
- Optimized for use as large-area snubber diode in GTO converters
- Industry standard press-pack ceramic housing, hermetically plasma-welded
- Cosmic radiation withstand rating

Blocking

V _{RRM}	Repetitive peak reverse voltage	4500 V	Half sine wave, t_P = 10 ms, f = 50 Hz		
I _{RRM}	Repetitive peak reverse current	\leq 200 mA	$V_{R} = V_{RRM,} T_{j} = 125^{\circ}C$		
V _{DClink}	Permanent DC voltage for 100 FIT failure rate	2400 V	100% Duty	Ambient cosmic radiation at sea level in open air.	
V_{DClink}	Permanent DC voltage for 100 FIT failure rate	2800 V	5% Duty		

Mechanical data (see Fig. 8)

F _m	Mounting force min		36 kN
Γm	max		44 kN
а	Acceleration: Device unclamped Device clamped		50 m/s ² 200 m/s ²
m	Weight		0.83 kg
Ds	Surface creepage distance	≥	30 mm
Da	Air strike distance	≥	20 mm

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On-state (see Fig. 2, 3)

I _{FAVM}	Max. average on-state current	900 A	Half sine wave, $T_c = 85^{\circ}C$
I _{FRMS}	Max. RMS on-state current	1400 A	
I _{FSM}	Max. peak non-repetitive	16 kA	tp = 10 ms Before surge:
	surge current	40 kA	$tp = 1 ms T_c = T_j = 125^{\circ}C$
∫l ² dt	Max. surge current integral	1.28.10 ⁶ A ² s	tp = 10 ms After surge:
		0.8·10 ⁶ A ² s	tp = 1 ms $V_R \approx 0 V$
V_{F}	Forward voltage drop	\leq 4.5 V	I _F = 3000 A
V_{F0}	Threshold voltage	1.8 V	Approximation for $T_j = 125^{\circ}C$
r _F	Slope resistance	0.9 mΩ	I _F = 5005000 A

Turn-on (see Fig. 4, 5)

V_{fr}	Peak forward recovery voltage	\leq	55 V	di/dt = 500 A/µs, T _j = 125°C
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Turn-off (see Fig. 6, 7)

I _{rr}	Reverse recovery current	\leq	260 A	$di/dt = 100 A/\mu s$, $I_F = 1000 A$,
Q _{rr}	Reverse recovery charge	VI	1700 µC	$T_j = 125^{\circ}C, R_s = 22\Omega, C_s = 0.22\mu F$

Thermal (see Fig. 1)

Tj	Operating junction temperature range	-40125°C		
T _{stg}	Storage temperature range	-40125°C		
R_{thJC}	Thermal resistance junction to case	≤ 24 K/kW	Anode side cooled	
		≤ 24 K/kW	Cathode side cooled	F _m =
		≤ 12 K/kW	Double side cooled	36… 44 kN
R_{thCH}	Thermal resistance case to heatsink	≤ 6 K/kW	Single side cooled	
		≤ 3 K/kW	Double side cooled	

Analytical function for transient thermal impedance.

$$Z_{\text{thJC}}(t) = \sum_{i=1}^{n} R_{i}(1 - e^{-t/\tau_{i}})$$

i	1	2	3	4		
R _i (K/kW)	7.44	2.00	1.84	0.71		
$\tau_i(s)$	0.47	0.091	0.011	0.0047		
F _m = 36 44 kN Double side cooled						

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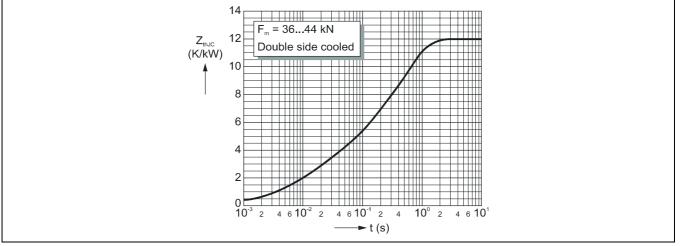


Fig. 1 Transient thermal impedance (junction-to-case) vs. time in analytical and graphical form (max. values).

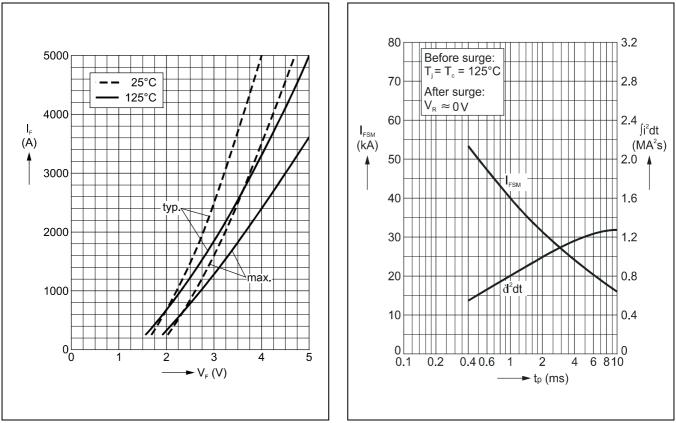


Fig. 2 Forward current vs. forward voltage (typ. and max. values) and linear approximation of max. curve at 125°C.

Fig. 3 Surge current and fusing integral vs. pulse width (max. values) for non-repetitive, half-sinusoidal surge current pulses.

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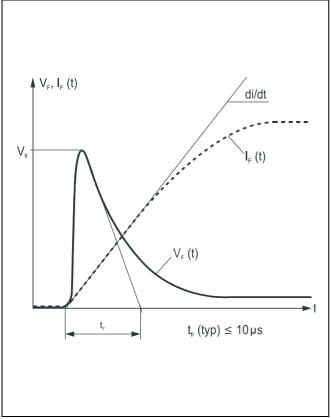


Fig. 4 Typical forward voltage waveform when the diode is turned on with a high di/dt.

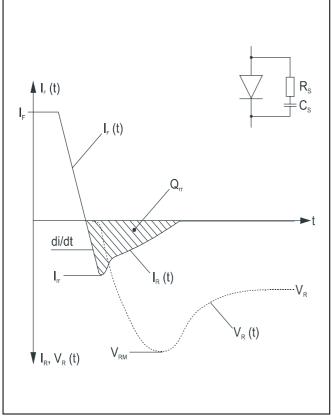


Fig. 6 Typical current and voltage waveforms at turn-off when the diode is connected to an RCD snubber, as often used in GTO circuits.

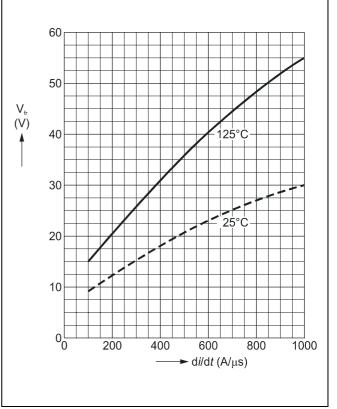


Fig. 5 Forward recovery voltage vs. turn-on di/dt (max. values).

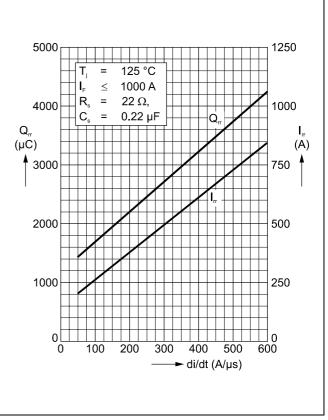


Fig. 7 Reverse recovery current vs. turn off di/dt (max. values).

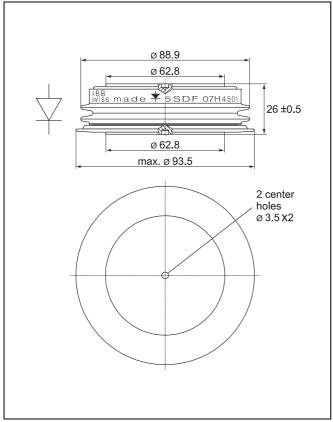


Fig. 8 Outline drawing. All dimensions are in millimeters and represent nominal values unless stated otherwise.

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Doc. No. 5SYA1111-02 Sep. 01